Search Notes



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SEARCHED

Class	Subclass	Date	Examiner
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SEARCH NOTES

Search Notes	Date	Examiner
EAST, IEEE, EPO, JPO, Internet Search	09/20/2007	AF
Consulted with Chieh M. Fan	06/26/2007	AF
Consulted with Ted Wang	06/26/2007	AF

INTERFERENCE SEARCH

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